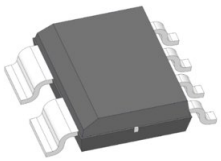
ACS37010 and ACS37012

450 kHz, High Accuracy Current Sensor
With FAULT or Reference Output

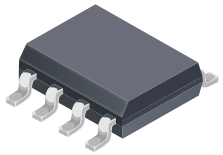
FEATURES AND BENEFITS

- High operating bandwidth and fast response time
  - 450 kHz bandwidth
  - 1.3 µs response time
- High-accuracy current measurements
  - ±1.5% sensitivity error over temperature
  - ±4 mV offset voltage over temperature
  - Nonratiometric operation with VREF output for enhanced accuracy in noisy environments
  - Differential sensing robust against external magnetic fields
  - Magnetic hysteresis-free operation
- Wide operating temperature, –40°C to 150°C
- Low internal primary conductor resistance (0.68 mΩ) for better power efficiency (low dissipation)
- Highly isolated compact surface-mount packages
- AEC-Q100 Grade 0, automotive qualified

PACKAGE



6-Pin Fused-Lead SOIC
(suffix LZ)



8-Pin SOIC
(suffix LC)

Not to scale

DESCRIPTION

The ACS37010 and ACS37012 are fully integrated current sensor ICs that sense current flowing through the compact LZ and LC packages. The low-resistance conductor is ideal for low power dissipation constraints. The sensor is factory-trimmed to provide high accuracy over the entire operating range without the need for customer programming.

The internal construction provides high isolation and excellent magnetic coupling of the field generated by the current flowing in the conductor and the fully monolithic Hall sensor IC. The current is sensed differentially by two Hall plates that subtract interfering common-mode magnetic fields. The sensor provides a very fast 1.3 µs response time analog output with VREF pin for use in noisy supply environments (ACS37010) or a fast logic alert fault output pin with factory pre-programmed trip point provides overcurrent or short-circuit detection and enhanced system protection (ACS37012). The IC has no physical connection to the integrated current conductor and provides high isolation (withstand strength of 3500 V_{RMS} for the LZ package and 2400 V_{RMS} for the LC package) between the primary and secondary signal leads of the package.

The ACS37010/12 is offered in a custom 6-pin SOIC package (suffix LZ) and a standard 8-pin SOIC package. Devices are RoHS-compliant and lead (Pb) free without the use of RoHS exemptions with 100% matte-tin-plated leadframes.

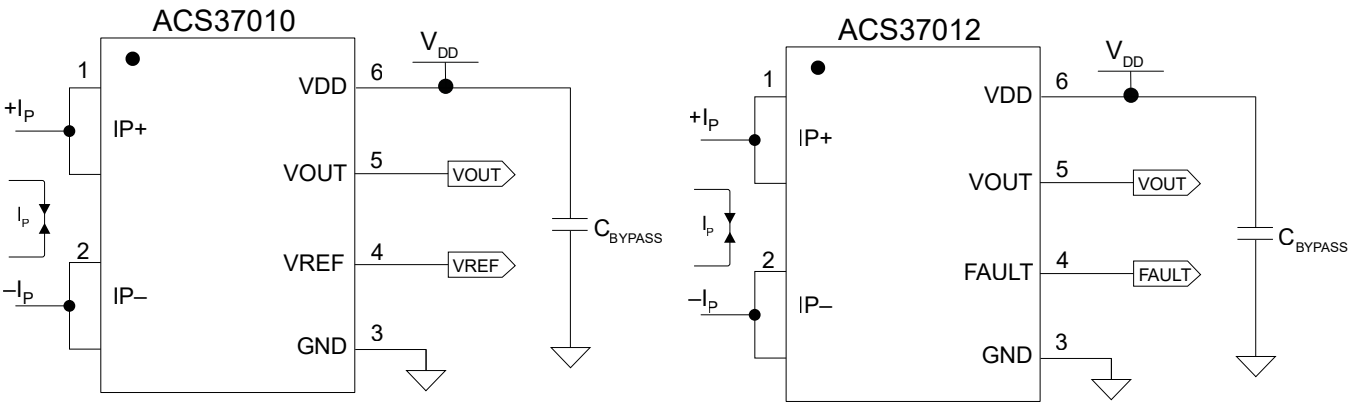


Figure 1: Typical Application Circuit

The device outputs an analog signal, V_{OUT}, that varies linearly with the AC or DC primary current, I_P, within the ranges specified.

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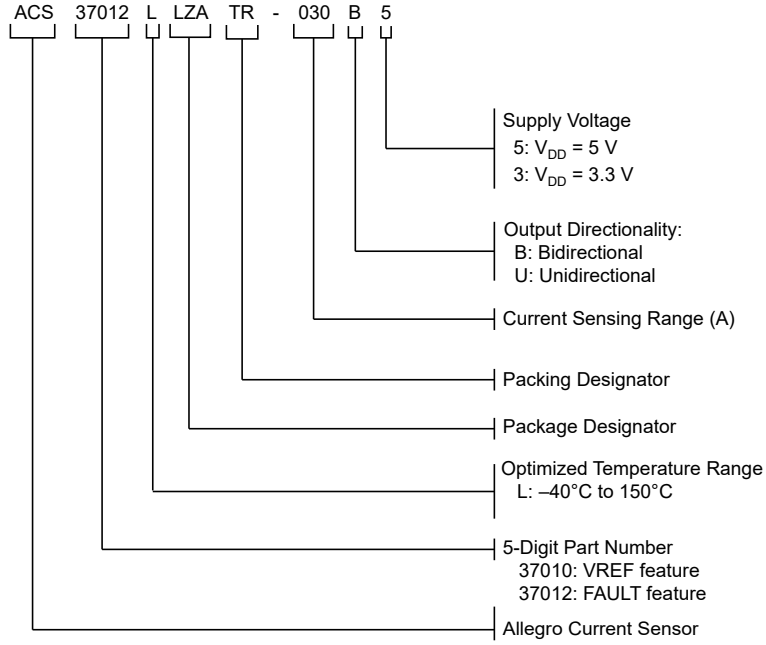
SELECTION GUIDE

Part Number	Current Sensing Range, I_{PR} (A)	Sensitivity (mV/A)	V_{DD} (V)	V_{QVO} (V)	Feature	Optimized Temperature Range T_A (°C)	Packing
LZ PACKAGE, 6-PIN FUSED-LEAD SOIC							
ACS37010LLZATR-030B5	±30	66.7	5	2.5	VREF	–40 to 150	Tape and Reel, 3000 pieces per reel
ACS37010LLZATR-030U5	30	133.3	5	0.5			
ACS37010LLZATR-030B3	±30	44	3.3	1.65			
ACS37010LLZATR-050B5	±50	40	5	2.5			
ACS37010LLZATR-050B3	±50	26.4	3.3	1.65			
ACS37012LLZATR-030B5	±30	66.7	5	2.5	FAULT		
ACS37012LLZATR-030B3	±30	44	3.3	1.65			
ACS37012LLZATR-050B5	±50	40	5	2.5			
ACS37012LLZATR-050B3	±50	26.4	3.3	1.65			
LC PACKAGE, 8-PIN SOIC							
ACS37010LLCTR-010B5	±10	200	5	2.5	VREF	–40 to 150	Tape and Reel, 3000 pieces per reel
ACS37010LLCTR-010B3	±10	132	3.3	1.65			
ACS37010LLCTR-050B5	±50	40	5	2.5			
ACS37010LLCTR-050B3	±50	26.4	3.3	1.65			
ACS37012LLCTR-010B5	±10	200	5	2.5	FAULT		
ACS37012LLCTR-010B3	±10	132	3.3	1.65			
ACS37012LLCTR-050B5	±50	40	5	2.5			
ACS37012LLCTR-050B3	±50	26.4	3.3	1.65			

PART NAMING SPECIFICATION



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ABSOLUTE MAXIMUM RATINGS [1]

Characteristic	Symbol	Notes	Min.	Max.	Unit
Supply Voltage	V_{DD}		–0.5	6.5	V
Output Voltage	V_O	Applies to V_{OUT}, V_{REF} or V_{FAULT}	–0.5	(V_{DD} + 0.7) ≤ 6.5	V
Operating Ambient Temperature	T_A		–40	150	°C
Storage Temperature	T_{STG}		–65	165	°C
Maximum Junction Temperature	$T_{J(MAX)}$	Sensing range of sensor is limited by $T_{J(MAX)}$ = 165°C	–	165	°C

[1] A stress that exceeds the absolute maximum rating listed might cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other condition that exceeds those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum ratings for extended periods might affect device reliability.

LZ ISOLATION CHARACTERISTICS

Characteristic	Symbol	Notes	Value	Units
Withstand Strength [1][2]	V_{ISO}	Agency rated for 60 seconds per UL 62368-1 (edition 3)	3500	V_{RMS}
Working Voltage for Basic Isolation [2]	V_{WVBI}	Maximum approved working voltage for basic (single) isolation according to UL 62368-1 (edition 3)	1188	V_{PK} or V_{DC}
			840	V_{RMS}
Working Voltage for Reinforced Isolation [2]	V_{WVRI}	Maximum approved working voltage for reinforced isolation according to UL 62368-1 (edition 3)	594	V_{PK} or V_{DC}
			420	V_{RMS}
Surge Voltage	V_{SURGE}	1.2/50 µs waveform, tested in dielectric fluid to determine the intrinsic surge immunity of the isolation barrier	13000	V_{PK}
Impulse Withstand	$V_{IMPULSE}$	1.2/50µs waveform, tested in air	5000	V_{RMS}
Clearance	D_{CL}	Minimum distance through air from IP leads to signal leads	4.1	mm
Creepage	D_{CR}	Minimum distance along package body from IP leads to signal leads	4.1	mm
Distance Through Insulation	DTI	Minimum internal distance through insulation	54	µm
Comparative Tracking Index	CTI	Material Group I	>600	V

[1] Production tested in accordance UL 62368-1 (edition 3).
[2] Certification pending.

LC ISOLATION CHARACTERISTICS

Characteristic	Symbol	Notes	Rating	Unit
Withstand Strength [1][2]	V_{ISO}	Agency rated for 60 seconds per UL 62368-1 (edition 3), < 125°C	2400	V_{RMS}
		Agency rated for 60 seconds per UL 62368-1 (edition 3), > 125°C	1768	V_{RMS}
Working Voltage for Basic Isolation [2]	V_{WVBI}	Maximum approved working voltage for basic (single) isolation according to UL 62368-1 (edition 3)	420	V_{PK} or V_{DC}
			297	V_{RMS}
Surge Voltage	V_{SURGE}	1.2/50 µs waveform, tested in dielectric fluid to determine the intrinsic surge immunity of the isolation barrier	5000	V_{PK}
Impulse Withstand	$V_{IMPULSE}$	1.2/50µs waveform, tested in air	4000	V_{PK}
Clearance	D_{CL}	Minimum distance through air from IP leads to signal leads	4	mm
Creepage	D_{CR}	Minimum distance along package body from IP leads to signal leads	4	mm
Distance Through Insulation	DTI	Minimum internal distance through insulation	44	µm
Comparative Tracking Index	CTI	Material Group II	400 to 599	V

[1] Production tested in accordance UL 62368-1 (edition 3).
[2] Certification pending.

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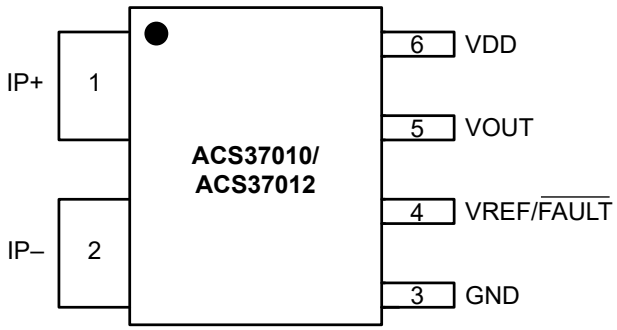
PACKAGE CHARACTERISTICS

Characteristic	Symbol	Notes		Min.	Typ.	Max.	Unit
Primary Conductor Resistance	R_{IP}	T_A = 25°C	LZ package	–	0.68	–	mΩ
			LC package	–	0.9	–	mΩ
Primary Conductor Inductance	L_{IP}	T_A = 25°C	LZ package	–	2.4	–	nH
			LC package	–	2	–	nH
Moisture Sensitivity Level	MSL	Per IPC/JEDEC J-STD-020		–	2	–	–

PINOUT DIAGRAM AND TERMINAL LIST TABLE

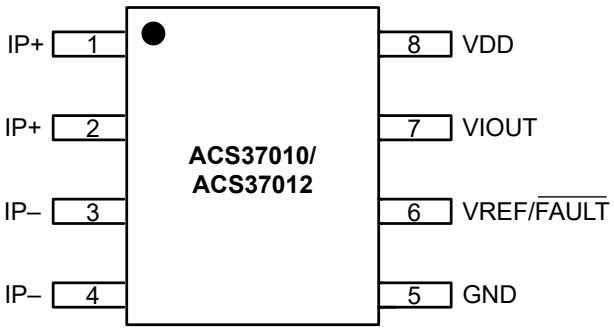


Pinout Diagram

Package LZ, 6-Pin SOIC

Terminal List Table

Number	Name	Description
1	IP+	Terminal for current being sensed
2	IP–	Terminal for current being sensed
3	GND	Device ground terminal
4	VREF/ FAULT	Zero-current voltage reference (ACS37010) or overcurrent fault output (ACS37012)
5	VOUT	Analog output
6	VDD	Device power supply terminal



Pinout Diagram

Package LC, 8-Pin SOIC

Terminal List Table

Number	Name	Description
1,2	IP+	Positive terminals for current being sensed; fused internally
3,4	IP–	Negative terminals for current being sensed; fused internally
5	GND	Device ground terminal
6	VREF/ FAULT	Zero current-voltage reference (ACS37010) or overcurrent fault output (ACS37012)
7	VOUT	Analog output
8	VDD	Device power supply terminal

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FUNCTIONAL BLOCK DIAGRAM

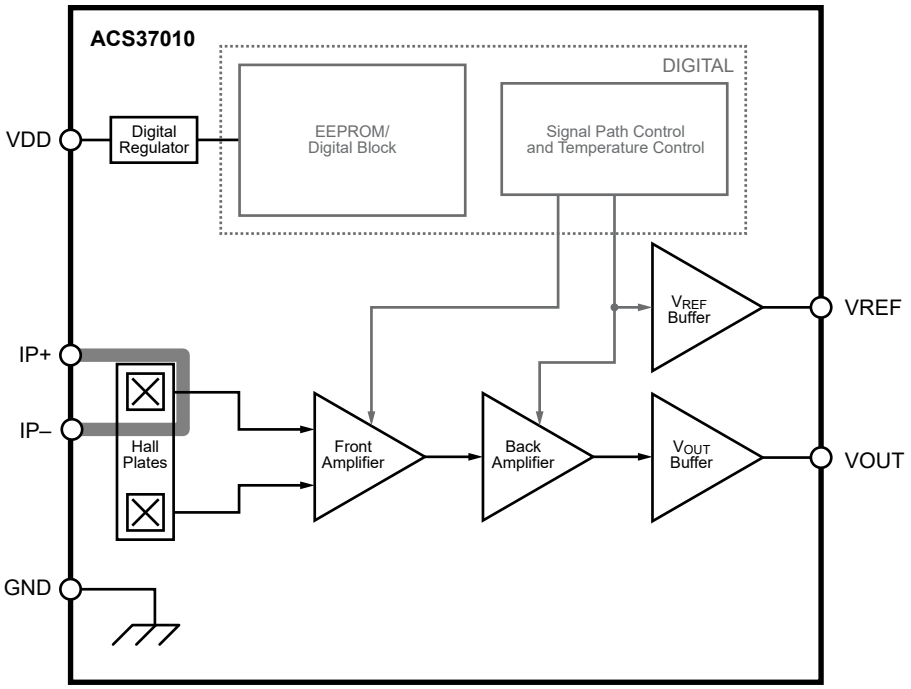

Figure 2: ACS37010 Functional Block Diagram

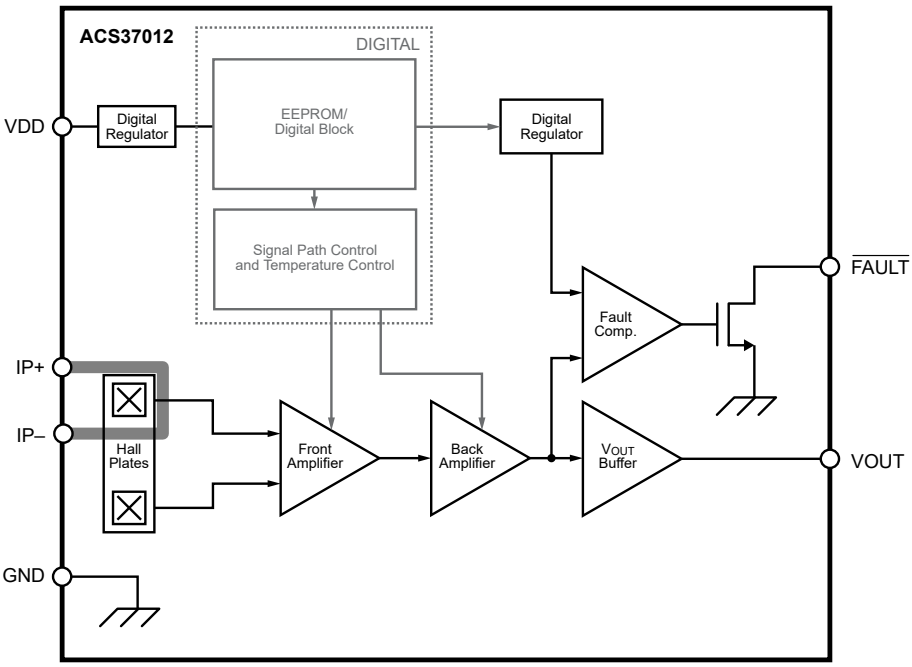

Figure 3: ACS37012 Functional Block Diagram

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COMMON ELECTRICAL CHARACTERISTICS: Valid over full operating temperature range, T_A = –40°C to 150°C, C_{BYPASS} = 100 nF, and V_{DD} = 5 V or 3.3 V, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Supply Voltage	V_{DD}	5 V variant	4.5	5	5.5	V
		3.3 V variant	3	3.3	3.6	V
Supply Current	I_{DD}	5 V variant, no load on VOUT or VREF	–	16	20	mA
		3.3 V variant, no load on VOUT or VREF	–	14	18	mA
Output Resistive Load	R_{L_VOUT}		10	–	–	kΩ
Output Capacitive Load [1]	C_{L_VOUT}		–	–	6	nF
Supply Bypass Capacitor	C_{BYPASS}		0.1	1	–	µF
Power-On Reset Release Voltage	V_{POR}	V_{DD} rising 1 V/ms	2.7	2.9	3	V
Power-On Reset Hysteresis	V_{POR_HYS}		250	300	500	mV
Power-On Time	t_{PO}	T_A = 25°C	–	65	–	µs
Undervoltage Detection Threshold [2]	V_{UVD}	T_A = 25°C, V_{DD} falling 1 V/ms	3.8	4.1	4.25	V
Undervoltage Detection Hysteresis [2]	V_{UVD_HYS}		200	250	400	mV
Undervoltage Detection Time [2]	t_{UVD}		–	70	200	µs
Undervoltage Detection Release Time [2]	t_{UVD_R}		–	6	–	µs
Overvoltage Detection Threshold	V_{OVD}	V_{DD} rising 1 V/ms	6.1	6.3	6.5	V
Overvoltage Detection Hysteresis	V_{OVD_HYS}	T_A = 25°C	400	500	600	mV
Overvoltage Detection Time	t_{OVD}		–	70	200	µs
Overvoltage Detection Release Time	t_{OVD_R}		–	3	–	µs
OUTPUT SIGNAL CHARACTERISTICS (VOUT)						
Rise Time	t_R	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF	–	1	2.5	µs
Response Time	t_{RESP}	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF	–	1.3	2.5	µs
Propagation Delay	t_{PD}	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF	–	0.7	1.5	µs
Bandwidth	BW	T_A = 25°C, Small Signal –3 dB, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF	–	450	–	kHz
Noise Density	N_D	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, 5 V variant	–	150	–	µA/√Hz
		T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, 3.3 V variant	–	230	–	µA/√Hz
Output Saturation Voltage [3]	V_{SAT_H}	R_{L_VOUT} = 10 kΩ to GND	V_{DD} – 0.25	–	–	V
	V_{SAT_L}	R_{L_VOUT} = 10 kΩ to VDD	–	–	0.15	V
Short-Circuit Current	I_{SC_VOUT}	T_A = 25°C, VOUT shorted to GND	–	25	–	mA
		T_A = 25°C, VOUT shorted to VDD	–	–25	–	mA
Common Mode Field Sensitivity	CMFS		–	4	–	mA/G

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COMMON ELECTRICAL CHARACTERISTICS (continued): Valid over full operating temperature range, T_A = –40°C to 150°C, C_{BYPASS} = 100 nF, and V_{DD} = 5 V or 3.3 V, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
REFERENCE OUTPUT CHARACTERISTICS (VREF)[4]						
VREF Resistive Load	R_{L_VREF}	VREF to GND or VREF to VDD	10	–	–	kΩ
VREF Capacitive Load	C_{L_VREF}	VREF to GND	–	1	6	nF
VREF Short-Circuit Current	I_{SC_VREF}	VREF shorted to GND	–	25	–	mA
		VREF shorted to VDD	–	–25	–	mA
OVERCURRENT CHARACTERISTICS (FAULT)[5]						
Overcurrent Operating Point	I_{OC}	Internally set as a percent of full-scale current	–	100	–	$\%I_{PR}$
FAULT Pull-Up Resistance	R_{L_FAULT}	FAULT to VDD	4.7	–	500	kΩ
Overcurrent Error	E_{OC}		–10	–	10	$\%I_{OC}$[6]
FAULT Output Low Voltage	V_{FAULT_L}	R_{L_FAULT} = 10 kΩ, fault condition present	–	–	0.4	V
FAULT Leakage Current	I_{FAULT_OFF}	R_{L_FAULT} = 10 kΩ, no fault condition present	–	100	500	nA
Overcurrent Hysteresis	I_{OC_HYS}		–	9.5	–	$\%I_{PR}$
Overcurrent Response Time	t_{OC_RESP}		–	1.7	2.7	µs

[1] Validated by design and characterization.
[2] Only enabled on 5 V devices.
[3] The sensor might continue to respond to current beyond the specified current sensing range, I_{PR}, until the output saturates at the high or low saturation voltage; however, the linearity and performance beyond the specified current sensing range are not validated.
[4] ACS37010 only.
[5] ACS37012 only.
[6] Where I_{OC} is the specific point at which the OCF trigger is to occur.

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ACS37010LLZATR-030B5 PERFORMANCE CHARACTERISTICS: Valid over full operating temperature range, T_A = –40°C to 150°C, C_{BYPASS} = 100 nF, and V_{DD} = 5 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–30	–	30	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	66.7	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	2.5	–	V
Reference Voltage Output	V_{REF}		–	2.5	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±0.8	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±0.8	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±5	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±5	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±5	8	mV
		T_A = –40°C to 25°C	–8	±5	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–4	±2	4	mV
		I_P = 0 A, T_A = –40°C to 25°C	–4	±2	4	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	8.5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.2	±0.7	1.2	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±6	9	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±6	9	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–8	±5	8	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–2.5	–	2.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–10	–	10	mV
		I_P = 0 A, T_A = –40°C to 25°C	–10	–	10	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–10	–	10	mV
		T_A = –40°C to 25°C	–10	–	10	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–3	–	3	mV
		I_P = 0 A, T_A = –40°C to 25°C	–3	–	3	mV

[1] Typical values are the mean ±3 sigma of production distributions.
[2] Validated by design and characterization.
[3] Lifetime drift minimum/maximum values are ±3 sigma, and are based on a statistical combination of production distributions and worst-case drift distributions observed after AEC-Q100 qualification stresses.

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ACS37010LLZATR-030U5 PERFORMANCE CHARACTERISTICS: Valid over full operating temperature range, T_A = –40°C to 150°C, C_{BYPASS} = 100 nF, and V_{DD} = 5 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	0	–	30	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	133.3	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	0.5	–	V
Reference Voltage Output	V_{REF}		–	0.5	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±5	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±5	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±5	8	mV
		T_A = –40°C to 25°C	–8	±5	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–4	±3	4	mV
		I_P = 0 A, T_A = –40°C to 25°C	–4	±3	4	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	17	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.2	±0.8	1.2	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±6	9	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±6	9	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–8	±5	8	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–2.5	–	2.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–10	–	10	mV
		I_P = 0 A, T_A = –40°C to 25°C	–10	–	10	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–10	–	10	mV
		T_A = –40°C to 25°C	–10	–	10	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–4	–	4	mV
		I_P = 0 A, T_A = –40°C to 25°C	–4	–	4	mV

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–30	–	30	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	44	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	1.65	–	V
Reference Voltage Output	V_{REF}		–	1.65	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±4	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±4	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±4	8	mV
		T_A = –40°C to 25°C	–8	±4	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–3	±1.5	3	mV
		I_P = 0 A, T_A = –40°C to 25°C	–3	±2	3	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	8.5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1.2	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–2.5	–	2.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–10	–	10	mV
		I_P = 0 A, T_A = –40°C to 25°C	–10	–	10	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–10	–	10	mV
		T_A = –40°C to 25°C	–10	–	10	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–3	–	3	mV
		I_P = 0 A, T_A = –40°C to 25°C	–3	–	3	mV

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–50	–	50	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	40	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	2.5	–	V
Reference Voltage Output	V_{REF}		–	2.5	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1.1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1.1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±5	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±5	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±5	8	mV
		T_A = –40°C to 25°C	–8	±5	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–4	±2	4	mV
		I_P = 0 A, T_A = –40°C to 25°C	–4	±2	4	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.2	±0.8	1.2	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±6	9	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±6	9	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–8	±5	8	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–3	–	3	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–15	–	15	mV
		I_P = 0 A, T_A = –40°C to 25°C	–15	–	15	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–15	–	15	mV
		T_A = –40°C to 25°C	–15	–	15	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–3	–	3	mV
		I_P = 0 A, T_A = –40°C to 25°C	–3	–	3	mV

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–50	–	50	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	26.4	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	1.65	–	V
Reference Voltage Output	V_{REF}		–	1.65	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1.1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±4	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±4	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±4	8	mV
		T_A = –40°C to 25°C	–8	±4	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–3	±1.5	3	mV
		I_P = 0 A, T_A = –40°C to 25°C	–3	±1.5	3	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1.1	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–2.5	–	2.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–13	–	13	mV
		I_P = 0 A, T_A = –40°C to 25°C	–13	–	13	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–13	–	13	mV
		T_A = –40°C to 25°C	–13	–	13	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–3	–	3	mV
		I_P = 0 A, T_A = –40°C to 25°C	–3	–	3	mV

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–30	–	30	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	66.7	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	2.5	–	V
Overcurrent FAULT Threshold	I_{OC}		–	100	–	$\%I_{PR}$
Overcurrent FAULT Hysteresis	I_{OC_HYS}		–	2.9	–	A
FAULT ERROR						
Overcurrent Error	I_{OC_E}		–3	–	3	A
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±0.8	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±0.8	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±5	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±5	8	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	8.5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.2	±0.7	1.2	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±6	9	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–2.5	–	2.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–10	–	10	mV
		I_P = 0 A, T_A = –40°C to 25°C	–10	–	10	mV

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–30	–	30	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	44	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	1.65	–	V
Overcurrent FAULT Threshold	I_{OC}		–	100	–	$\%I_{PR}$
Overcurrent FAULT Hysteresis	I_{OC_HYS}		–	2.9	–	A
FAULT ERROR						
Overcurrent Error	I_{OC_E}		–3	–	3	A
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±4	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±4	8	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	8.5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1.2	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–2.5	–	2.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–10	–	10	mV
		I_P = 0 A, T_A = –40°C to 25°C	–10	–	10	mV

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–50	–	50	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	40	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	2.5	–	V
Overcurrent FAULT Threshold	I_{OC}		–	100	–	$\%I_{PR}$
Overcurrent FAULT Hysteresis	I_{OC_HYS}		–	4.8	–	A
FAULT ERROR						
Overcurrent Error	I_{OC_E}		–5	–	5	A
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1.1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1.1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±5	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±5	8	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.2	±0.8	1.2	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±6	9	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–3	–	3	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–15	–	15	mV
		I_P = 0 A, T_A = –40°C to 25°C	–15	–	15	mV

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–50	–	50	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	26.4	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	1.65	–	V
Overcurrent FAULT Threshold	I_{OC}		–	100	–	$\%I_{PR}$
Overcurrent FAULT Hysteresis	I_{OC_HYS}		–	4.8	–	A
FAULT ERROR						
Overcurrent Error	I_{OC_E}		–5	–	5	A
ERROR COMPONENTS						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1.1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±4	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±4	8	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1.1	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–2.5	–	2.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–3.5	–	3.5	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–13	–	13	mV
		I_P = 0 A, T_A = –40°C to 25°C	–13	–	13	mV

[1] Typical values are the mean ±3 sigma of production distributions.
[2] Validated by design and characterization.
[3] Lifetime drift minimum/maximum values are ±3 sigma, and are based on a statistical combination of production distributions and worst-case drift distributions observed after AEC-Q100 qualification stresses.

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ACS37010LLCTR-010B5 PERFORMANCE CHARACTERISTICS: Valid over full operating temperature range, T_A = –40°C to 150°C, C_{BYPASS} = 100 nF, and V_{DD} = 5 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–10	–	10	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	200	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	2.5	–	V
Reference Voltage Output	V_{REF}		–	2.5	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±3	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±3	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±3	8	mV
		T_A = –40°C to 25°C	–8	±3	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–5	±3	5	mV
		I_P = 0 A, T_A = –40°C to 25°C	–5	±3	5	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	12	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.2	±0.7	1.2	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±4	9	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±3	9	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–8	±3	8	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–	±1.3	–	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–	±1.3	–	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±2.7	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±2.7	–	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–	±3.5	–	mV
		T_A = –40°C to 25°C	–	±3.5	–	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±1.4	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±1.4	–	mV

[1] Typical values are the mean ±3 sigma of production distributions.
[2] Validated by design and characterization.
[3] Lifetime drift characteristics are based on the AEC-Q100 qualification results from zero-hour reads. Typical values are the worst-case mean drift observed during AEC-Q100 qualification from any of the –40°C, 25°C, or 150°C temperatures.

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–10	–	10	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	132	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	1.65	–	V
Reference Voltage Output	V_{REF}		–	1.65	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±2	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±2	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±2	8	mV
		T_A = –40°C to 25°C	–8	±2	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–5	±2	5	mV
		I_P = 0 A, T_A = –40°C to 25°C	–5	±2	5	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	12	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±2	6	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–	±1.3	–	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–	±1.3	–	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±2.7	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±2.7	–	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–	±3.5	–	mV
		T_A = –40°C to 25°C	–	±3.5	–	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±1.4	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±1.4	–	mV

[1] Typical values are the mean ±3 sigma of production distributions.
[2] Validated by design and characterization.
[3] Lifetime drift characteristics are based on the AEC-Q100 qualification results from zero-hour reads. Typical values are the worst-case mean drift observed during AEC-Q100 qualification from any of the –40°C, 25°C, or 150°C temperatures.

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–50	–	50	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	40	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	2.5	–	V
Reference Voltage Output	V_{REF}		–	2.5	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±2	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±2	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±2	8	mV
		T_A = –40°C to 25°C	–8	±2	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–4	±1	4	mV
		I_P = 0 A, T_A = –40°C to 25°C	–4	±1	4	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.2	±0.7	1.2	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±3	9	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±3	9	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–8	±3	8	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–	±1.3	–	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–	±1.3	–	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±2.7	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±2.7	–	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–	±3.5	–	mV
		T_A = –40°C to 25°C	–	±3.5	–	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±1.4	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±1.4	–	mV

[1] Typical values are the mean ±3 sigma of production distributions.
[2] Validated by design and characterization.
[3] Lifetime drift characteristics are based on the AEC-Q100 qualification results from zero-hour reads. Typical values are the worst-case mean drift observed during AEC-Q100 qualification from any of the –40°C, 25°C, or 150°C temperatures.

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–50	–	50	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	26.4	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	1.65	–	V
Reference Voltage Output	V_{REF}		–	1.65	–	V
ERROR COMPONENTS [1]						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±2	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±2	8	mV
Reference Voltage Output Error	V_{REF_E}	T_A = 25°C to 150°C	–8	±2	8	mV
		T_A = –40°C to 25°C	–8	±2	8	mV
Offset Error	V_{OE}	I_P = 0 A, T_A = 25°C to 150°C	–4	±1	4	mV
		I_P = 0 A, T_A = –40°C to 25°C	–4	±1	4	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±2	6	mV
Power Supply Reference Voltage Output Error	V_{REF_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±2	6	mV
Power Supply Offset Error	V_{OE_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±2	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–	±1.3	–	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–	±1.3	–	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±2.7	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±2.7	–	mV
Reference Voltage Output Error Including Lifetime Drift	V_{REF_LTD}	T_A = 25°C to 150°C	–	±3.5	–	mV
		T_A = –40°C to 25°C	–	±3.5	–	mV
Offset Error Including Lifetime Drift	V_{OE_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±1.4	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±1.4	–	mV

[1] Typical values are the mean ±3 sigma of production distributions.
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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–10	–	10	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	200	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	2.5	–	V
Overcurrent FAULT Threshold	I_{OC}		–	100	–	$\%I_{PR}$
Overcurrent FAULT Hysteresis	I_{OC_HYS}		–	0.95	–	A
FAULT ERROR						
Overcurrent Error	I_{OC_E}		–1	–	1	A
ERROR COMPONENTS						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±3	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±3	8	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	12	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.2	±0.7	1.2	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–9	±4	9	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–	±1.3	–	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–	±1.3	–	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±2.7	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±2.7	–	mV

[1] Typical values are the mean ±3 sigma of production distributions.
[2] Validated by design and characterization.
[3] Lifetime drift characteristics are based on the AEC-Q100 qualification results from zero-hour reads. Typical values are the worst-case mean drift observed during AEC-Q100 qualification from any of the –40°C, 25°C, or 150°C temperatures.

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–10	–	10	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	132	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	1.65	–	V
Overcurrent FAULT Threshold	I_{OC}		–	100	–	$\%I_{PR}$
Overcurrent FAULT Hysteresis	I_{OC_HYS}		–	0.95	–	A
FAULT ERROR						
Overcurrent Error	I_{OC_E}		–1	–	1	A
ERROR COMPONENTS						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±2	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±2	8	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	12	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±3	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–	±1.3	–	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–	±1.3	–	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±2.7	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±2.7	–	mV

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Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–50	–	50	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	26.4	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	2.5	–	V
Overcurrent FAULT Threshold	I_{OC}		–	100	–	$\%I_{PR}$
Overcurrent FAULT Hysteresis	I_{OC_HYS}		–	4.8	–	A
FAULT ERROR						
Overcurrent Error	I_{OC_E}		–5	–	5	A
ERROR COMPONENTS						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±2	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±2	8	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±2	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–	±1.3	–	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–	±1.3	–	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±2.7	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±2.7	–	mV

[1] Typical values are the mean ±3 sigma of production distributions.
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[3] Lifetime drift characteristics are based on the AEC-Q100 qualification results from zero-hour reads. Typical values are the worst-case mean drift observed during AEC-Q100 qualification from any of the –40°C, 25°C, or 150°C temperatures.

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ACS37012LLCTR-050B3 PERFORMANCE CHARACTERISTICS: Valid over full operating temperature range, T_A = –40°C to 150°C, C_{BYPASS} = 100 nF, and V_{DD} = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Units
NOMINAL PERFORMANCE						
Current Sensing Range [2]	I_{PR}	Limited by $T_{J(MAX)}$ = 165°C	–50	–	50	A
Sensitivity	Sens	$I_{PR(MIN)} < I_P < I_{PR(MAX)}$	–	26.4	–	mV/A
Quiescent Voltage Output	V_{QVO}	I_P = 0 A	–	1.65	–	V
Overcurrent FAULT Threshold	I_{OC}		–	100	–	$\%I_{PR}$
Overcurrent FAULT Hysteresis	I_{OC_HYS}		–	4.8	–	A
FAULT ERROR						
Overcurrent Error	I_{OC_E}		–5	–	5	A
ERROR COMPONENTS						
Sensitivity Error	E_{SENS}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–1.5	±1	1.5	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–1.5	±1	1.5	%
Quiescent Voltage Output Error	V_{QVO_E}	I_P = 0 A, T_A = 25°C to 150°C	–8	±2	8	mV
		I_P = 0 A, T_A = –40°C to 25°C	–8	±2	8	mV
Noise	N	T_A = 25°C, C_{L_VOUT} = 6 nF, C_{BYPASS} = 1 µF, BW = 450 kHz	–	5	–	mV_{RMS}
Power Supply Sensitivity Error	E_{SENS_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–1.4	±1	1.4	%
Power Supply Quiescent Voltage Output Error	V_{QVO_PS}	$V_{DD(MIN)}$ to $V_{DD(MAX)}$	–6	±2	6	mV
ERROR COMPONENTS INCLUDING LIFETIME DRIFT [2][3]						
Sensitivity Error Including Lifetime Drift	E_{SENS_LTD}	$I_P = 0.5 \times I_{PR(MAX)}$, T_A = 25°C to 150°C	–	±1.3	–	%
		$I_P = 0.5 \times I_{PR(MAX)}$, T_A = –40°C to 25°C	–	±1.3	–	%
Quiescent Voltage Output Error Including Lifetime Drift	V_{QVO_LTD}	I_P = 0 A, T_A = 25°C to 150°C	–	±2.7	–	mV
		I_P = 0 A, T_A = –40°C to 25°C	–	±2.7	–	mV

[1] Typical values are the mean ±3 sigma of production distributions.
[2] Validated by design and characterization.
[3] Lifetime drift characteristics are based on the AEC-Q100 qualification results from zero-hour reads. Typical values are the worst-case mean drift observed during AEC-Q100 qualification from any of the –40°C, 25°C, or 150°C temperatures.

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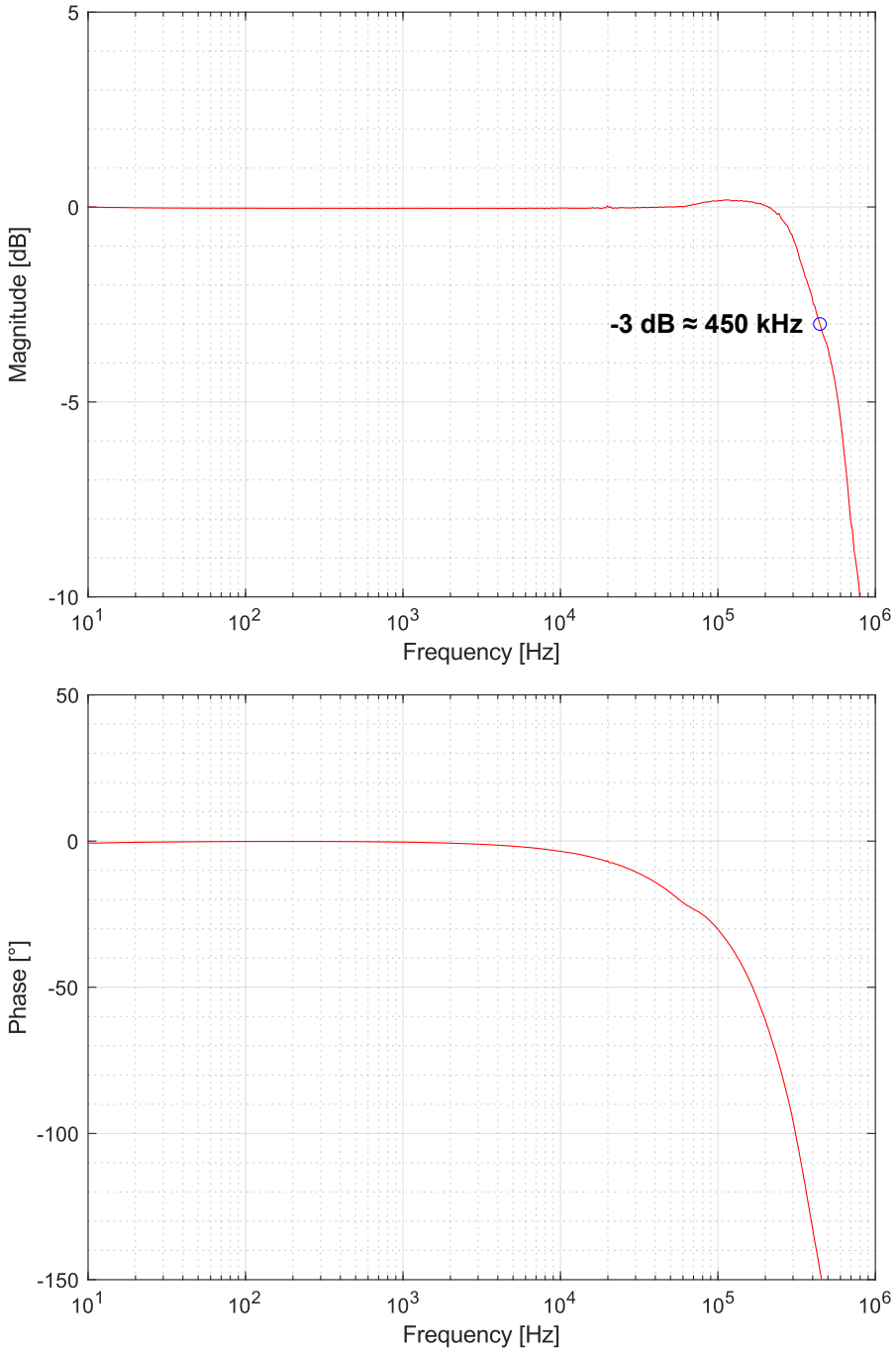
CHARACTERISTIC PERFORMANCE

ACS37010 and ACS37012 Typical Frequency Response



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RESPONSE CHARACTERISTICS DEFINITIONS AND TYPICAL PERFORMANCE DATA

Response Time ($t_{RESPONSE}$)

The time interval between a) when the sensed input current reaches 90% of its final value, and b) when the sensor output reaches 90% of its full-scale value.

Propagation Delay (t_{pd})

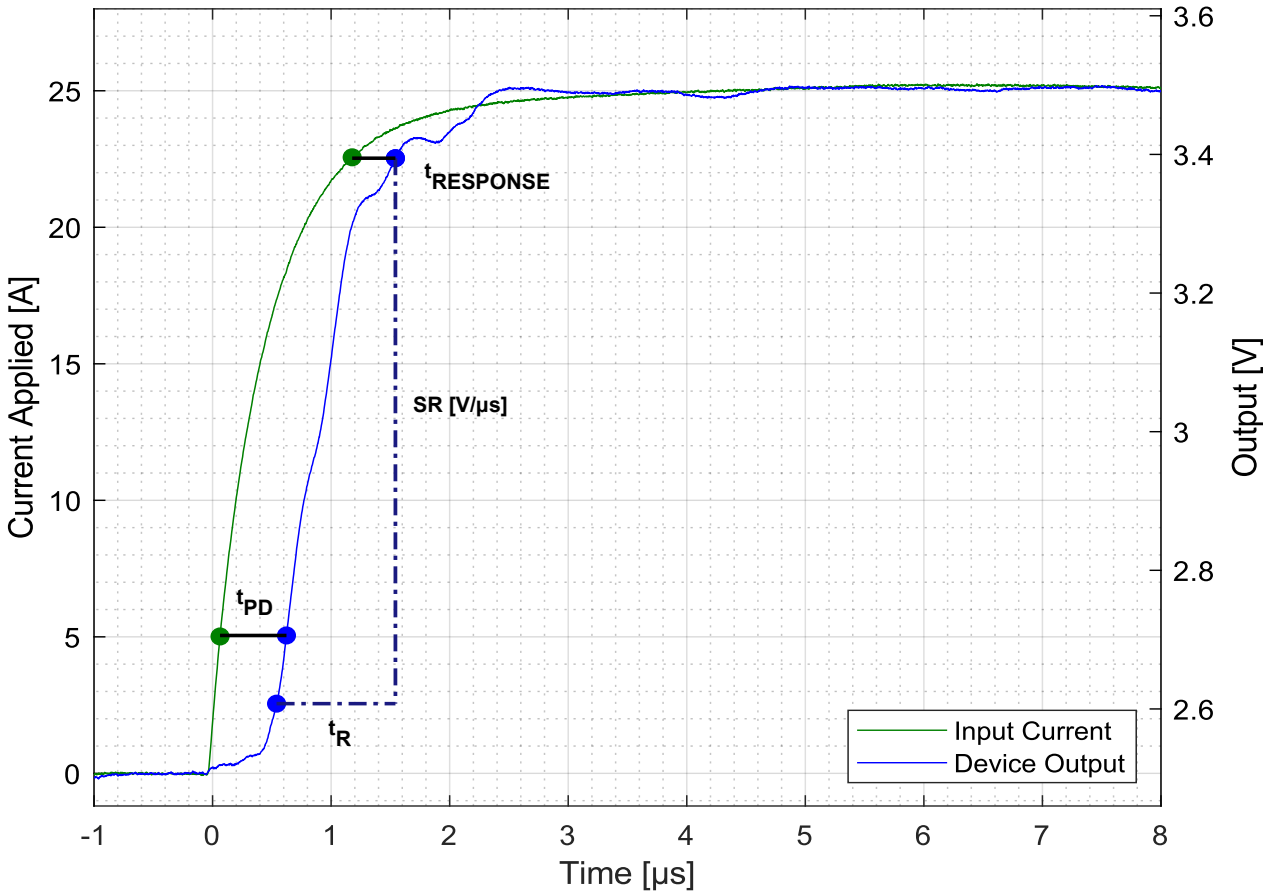
The time interval between a) when the sensed input current reaches 20% of its full-scale value, and b) when the sensor output reaches 20% of its full-scale value.

Rise Time (t_r)

The time interval between a) when the sensor reaches 10% of its full-scale value, and b) when the sensor reaches 90% of its full-scale value.

Output Slew Rate (SR)

The rate of change [V/µs] in the output voltage between a) when the sensor reaches 10% of its full-scale value, and b) when the sensor reaches 90% of its full-scale value.



Applied current step with 10% to 90% rise time = 1 µs
Test Conditions: T_A = 25°C, C_{BYPASS} = 1 µF, C_{L_VOUT} = 6 nF

Figure 4: Response Time, Propagation Delay, Rise Time, and Output Slew Rate

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FUNCTIONAL DESCRIPTION OF POWER ON/OFF OPERATION

Introduction

To ensure that the device output is reporting accurately, the ACS37010/12 contains an overvoltage and an undervoltage detection flag. This internal flag on V_{OUT} can be used to alert the system when the supply voltage for the device is beyond the operational range by putting the output into a known high-impedance (high Z) state. UVD is only active on 5 V devices.

V_{OUT} is plotted moving with V_{DD} in Figure 5 through Figure 10. During a high-impedance state, the voltage of V_{OUT} is most consistent with a known load (R_{L_VOUT}, C_{L_VOUT}). The plots in this section all use the same labeling scheme for different power thresholds, and references in brackets "[ ]" are valid for each of these plots.

NOTE: Any mention of VREF applies to ACS37010 only.

POWER-ON OPERATION

UVD Enabled

When UVD is enabled, as V_{DD} ramps up, the AC37010 V_{OUT} and V_{REF} pins are high Z until V_{DD} reaches and exceeds V_{UVD} [2] and V_{POR} [1], respectively. Once V_{DD} exceeds these thresholds, before the device can enter the typical operation mode, the device requires a period of time where V_{DD} does not reduce to less than $V_{POR} - V_{POR_HYS}$ [8].

UVD Disabled

When UVD is disabled, as V_{DD} ramps up, the AC37010 V_{OUT} and V_{REF} pins are high Z until V_{DD} reaches and exceeds V_{POR} [1]. Once V_{DD} exceeds V_{POR} [1], V_{OUT} enters typical operation.

POWER-OFF OPERATION

UVD Enabled

When UVD is enabled, before the device powers off, if V_{DD} reaches less than $V_{UVD} - V_{UVD_HYS}$ [6], V_{OUT} is forced to GND. When $V_{POR} - V_{POR_HYS}$ [8] is reached, V_{OUT} and V_{REF} become high Z.

UVD Disabled

When UVD is disabled, V_{REF} and V_{OUT} continue to report until V_{DD} is less than $V_{POR} - V_{POR_HYS}$ [8], at which point,V_{OUT} and V_{REF} enter a high Z state.

NOTE: Because the device is entering a high Z state and is not driving the output, the time required for the output to reach a steady state depends on the external circuitry.

Voltage Thresholds

POWER-ON RESET RELEASE VOLTAGE(V_{POR})

If V_{DD} reduces to less than $V_{POR} - V_{POR_HYS}$ [8] while in operation, the digital circuitry turns off and the output re-enters a high Z state. After V_{DD} recovers and exceeds V_{UVD} [2], a delay of t_{PO} occurs, then the output begins to report again.

UNDERVOLTAGE DETECTION THRESHOLD (V_{UVD})

The 5 V devices are factory-programmed with UVD enabled. It is important to note that, after a power-on-reset event, upon initial device power-up, V_{OUT} and V_{REF} remain high Z until V_{DD} increases to greater than V_{UVD} [2] and V_{POR} [1] respectively, at which point the V_{OUT} and V_{REF} outputs begin to resume typical operation. For 3.3 V device variants used in the same condition, if UVD is disabled, after V_{DD} increases to greater than V_{POR} [1], V_{OUT} and V_{REF} begin typical operation.

After typical operation begins, if V_{DD} reduces to less than $V_{UVD} - V_{UVD_HYS}$ [6], V_{OUT} pulls to GND regardless of R_{L_VOUT} configuration. The V_{OUT} remains at GND until V_{DD} increases to greater than V_{UVD} [1] or V_{DD} reduces to less than $V_{POR} - V_{POR_HYS}$ [8]. After a UVD event, if V_{DD} increases to greater than V_{UVD} [1], the V_{OUT} and V_{REF} outputs resume operation. If V_{DD} reduces to less than $V_{PO} - V_{POR_HYS}$ [8], the device enters a POR event and resets; if this occurs, V_{OUT} and V_{REF} switch to high Z.

OVERVOLTAGE DETECTION THRESHOLD (V_{OVD})

When V_{DD} increases to greater than V_{OVD} [4], the output of the V_{OUT} pin becomes high Z, V_{REF} remains in typical operation, and V_{OUT} becomes pulled to either VDD or GND, depending on the configuration (pull-up vs. pull-down) of R_{L_VOUT}.

OVERVOLTAGE/UNDERVOLTAGE DETECTION HYSTERESIS (V_{OVD_HYS}, V_{UVD_HYS})

To reduce nuisance flagging and clears, hysteresis is present between enable and disable thresholds.

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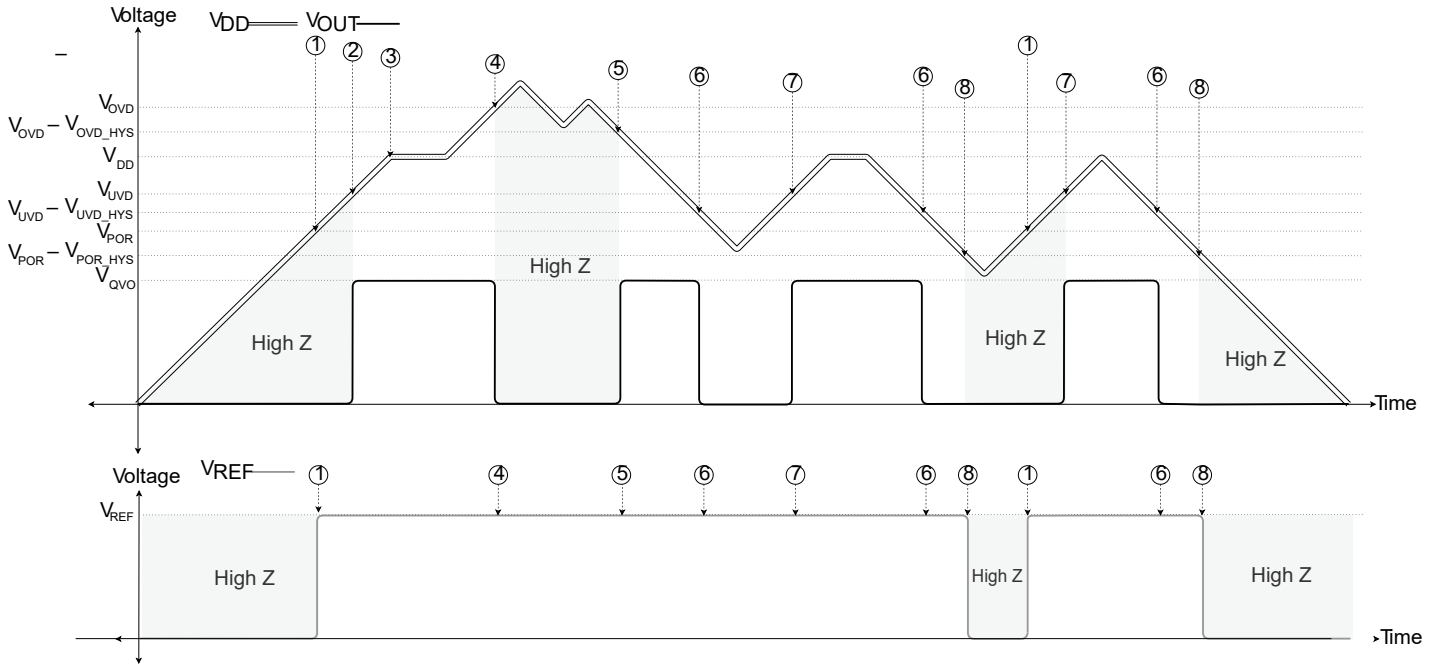

Figure 5: Power-State Thresholds with V_{OUT} and V_{REF} Behavior for a 5 V Device, R_{L_VOUT} = Pull-Down, UVD Enabled

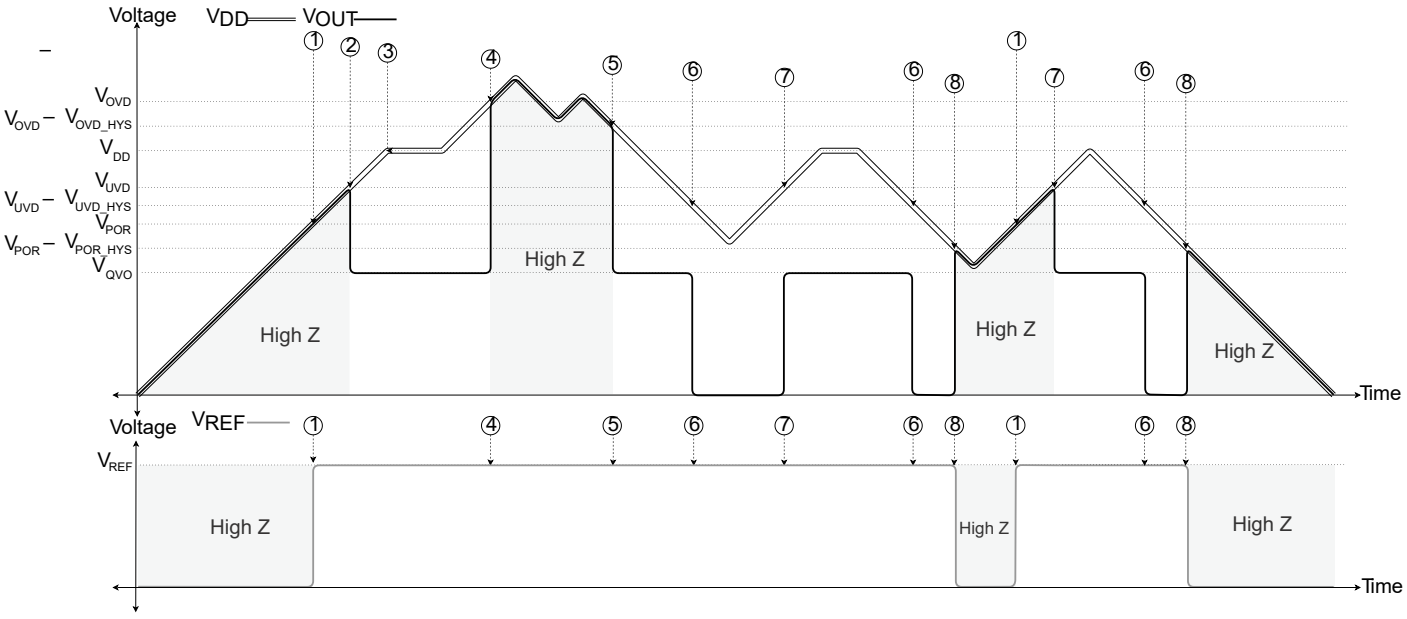

Figure 6: Power-State Thresholds with V_{OUT} and V_{REF} Behavior, 5 V Device, R_{L_VOUT} = Pull-Up, UVD Enabled

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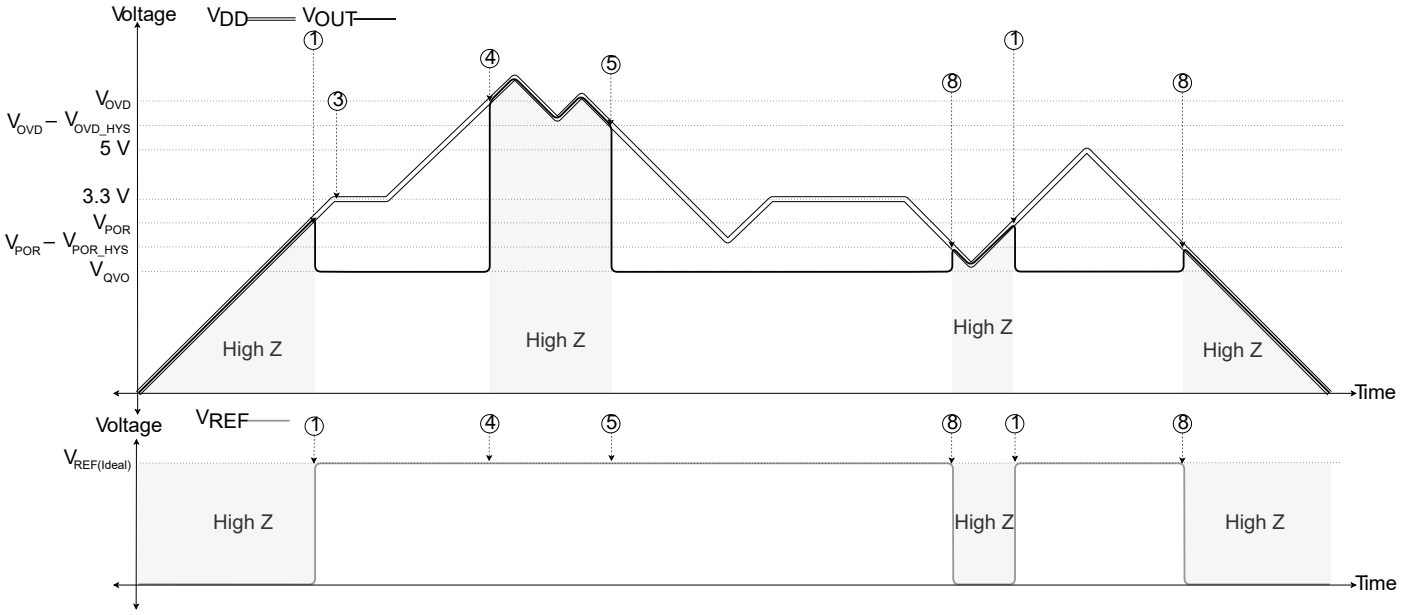

Figure 7: Power-State Thresholds with V_{OUT} and V_{REF} Behavior, 3.3 V Device, R_L = Pull-Up, UVD Disabled

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Timing Thresholds

POWER-ON DELAY (t_{PO})

When the supply is ramped to V_{UVD} [2], the device requires a finite period of time to power its internal components before the outputs are released from high Z and can respond to an input magnetic field. Power-on time, t_{PO}, is defined as the time it takes for the output voltage to settle within ±10% of its steady-state value under an applied magnetic field, which can be observed as the time from [2] to [A] in Figure 8. After this delay, the output quickly approaches $V_{OUT(IP)} = Sens \times I_P + V_{REF}$.

OVERVOLTAGE AND UNDERVOLTAGE DETECTION TIME AND DETECTION RELEASE TIME (t_{OVD}/t_{OVD_R}, t_{UVD}/t_{UVD_R})

The enable time for OVD, t_{OVD}, is the time from V_{OVD} [4] to OVD flag [B]. The UVD enable time, t_{UVD}, is the time from $V_{UVD} - V_{UVD_HYS}$ [6] to the UVD flag [D].

If V_{DD} ramps from greater than $V_{UVD} - V_{UVD_HYS}$ [6] to less than $V_{POR} - V_{POR_HYS}$ [8] faster than t_{UVD}, the device does not have time to report a UVD event before power-off occurs.

The detection release time for OVD, t_{OVD_R}, is the time from $V_{OVD} - V_{OVD_HYS}$ [5] to the OVD clear to typical operation [C]. The UVD disable time, t_{UVD_R}, is the time from V_{UVD} [7] to the point that the UVD flag clears and V_{OUT} returns to nominal operation [E]. The disable time does not have a counter for either OVD or UVD to release the output and resume reporting.

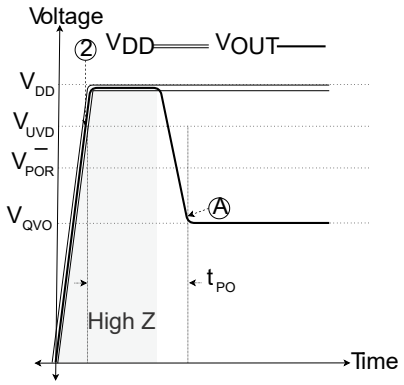

Figure 8: t_{PO} Behavior UVD Enabled, R_{L_VOUT} = Pull-Up

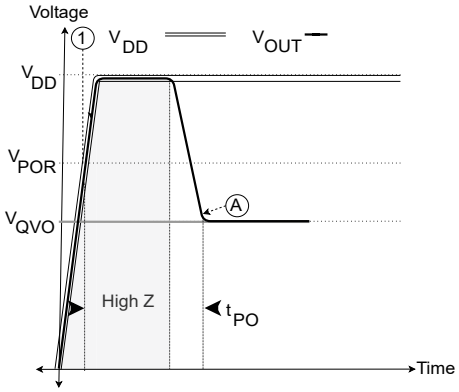

Figure 9: t_{PO} Behavior UVD Disabled, R_{L_VOUT} = Pull-Up

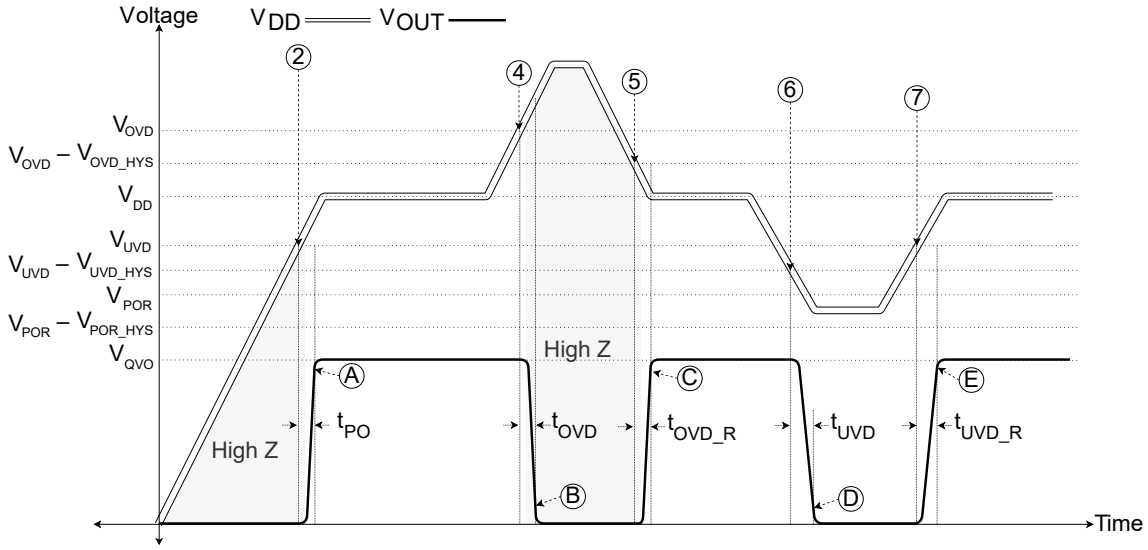

Figure 10: t_{PO}, and t_{OVD}/t_{OVD_R}, and t_{UVD}/t_{UVD_R} with R_{L_VOUT} = Pull-Up

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DEFINITIONS OF OPERATING AND PERFORMANCE CHARACTERISTICS

Quiescent Voltage Output (V_{QVO})

Quiescent voltage output, V_{QVO}, is defined as the voltage on the output, V_{OUT}, when zero amperes are applied through I_P.

Quiescent Voltage Output Error(V_{QVO_E})

Quiescent voltage output error, V_{QVO_E}, is defined as the drift of V_{QVO} from room to hot or room to cold (25°C to 150°C or 25°C to –40°C, respectively). To improve overtemperature performance, the temperature drift is compensated with Allegro factory trim to remain within the limits across temperature.

Reference Voltage Output (V_{REF})

The reference voltage output, V_{REF}, reports the quiescent voltage output for the output channel, V_{OUT}. The internally generated V_{REF} is used in a pseudo-differential mode to remove errors due to the reference shifts or noise on the ground line.

Reference Voltage Temperature Drift (V_{REF_E})

Reference voltage output error, V_{REF_E}, is defined as the drift of V_{REF} from room to hot or room to cold (25°C to 150°C or 25°C to –40°C, respectively).

Offset Error (V_{OE})

Offset error, V_{OE}, is defined as the difference between V_{QVO} and V_{REF}. V_{OE} includes V_{QVO_E} – V_{REF} from room to hot or room to cold (25°C to 150°C or 25°C to –40°C, respectively).

Output Saturation Voltage (V_{SAT_H} /V_{SAT_L})

Output saturation voltage, V_{SAT}, is defined as the voltage that the V_{OUT} does not pass as a result of an increasing magnitude of current. V_{SAT_H} is the highest voltage the output can drive to, while V_{SAT_L} is the lowest. Note that changing the sensitivity does not change the V_{SAT} points.

Sensitivity (Sens)

Sensitivity, Sens, is the ratio of the output swing versus the applied current through the primary conductor, I_P. This current causes a voltage deviation away from V_{QVO} on the V_{OUT} output until V_{SAT}. The magnitude and direction of the output voltage swing is proportional to the magnitude and direction of the applied current. This proportional relationship between output and input is sensitivity and is defined as:

$$Sens = \frac{V_{OUT(IP_1)} - V_{OUT(IP_2)}}{IP_1 - IP_2}$$

where IP_1 and IP_2 are two different currents, and $V_{OUT(IP1)}$ and $V_{OUT(IP2)}$ are the voltages of the device at those respective applied currents.

Sensitivity Error (E_{SENS})

Sensitivity error, E_{SENS}, is the error of sensitivity from room to hot or room to cold (25°C to 150°C or 25°C to –40°C, respectively). Sensitivity error is compensated with Allegro factory trim.

Error Components Including Lifetime Drift (E_{SENS_LTD}/V_{QVO_LTD}/V_{REF_LTD}/V_{OE_LTD})

Lifetime drift characteristics are based on a statistical combination of production distributions and worst-case distribution of parametric drift of individuals observed during AEC-Q100 qualification. Solder reflow induces stress on the ACS37010/12 device, causing parametric shifts; lifetime drift limits apply immediately after solder reflow, as well as after long-term use.

Power Supply Sensitivity Error (E_{SENS_PS})

Power supply sensitivity error, E_{SENS_PS}, is defined as the percent sensitivity error measured between V_{DD} and V_{DD} ±10%. For a 5 V device, this is 5 to 4.5 V and 5 to 5.5 V. For a 3.3 V device, this is 3.3 to 3 V and 3.3 to 3.6 V.

Power Supply Offset Error (V_{OE_PS})

Power supply offset error, V_{OE_PS}, is defined as the offset error in mV between V_{DD} and V_{DD} ±10% V_{DD}. For a 5 V device, this is 5 to 4.5 V and 5 to 5.5 V. For a 3.3 V device, this is 3.3 to 3 V and 3.3 to 3.6 V.

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OVERCURRENT FAULT (OCF) BEHAVIOR

The overcurrent fault (OCF) function (ACS37012 only) pulls the open-drain FAULT pin low when the applied current exceeds a preset threshold (I_{OCR}). On the ACS37012, this threshold is internally set to 100% of the full-scale rated current. This flag trips symmetrically for positive and negative applied currents.

The implementation of the OCF circuitry is accurate over temperature and does not require further temperature compensation.

OVERCURRENT ERROR (I_{OC_E})

Overcurrent error, I_{OC_E}, is the error between the ideal I_{OC} and the measured I_{OC}.

OVERCURRENT HYSTERESIS (I_{OC_HYS})

Overcurrent hysteresis, I_{OC_HYST}, is defined as the magnitude of current in percentage of the full scale that must reduce before a fault assertion is cleared. This can be observed as the separation between voltages [9] to [10] in Figure 11.

OVERCURRENT FAULT RESPONSE TIME (t_{OC_RESP})

Overcurrent response time, t_{OC_RESP}, is defined as the time from when the input reaches the operating point [9] until the OCF pin reduces to less than V_{FAULT_L} [G].

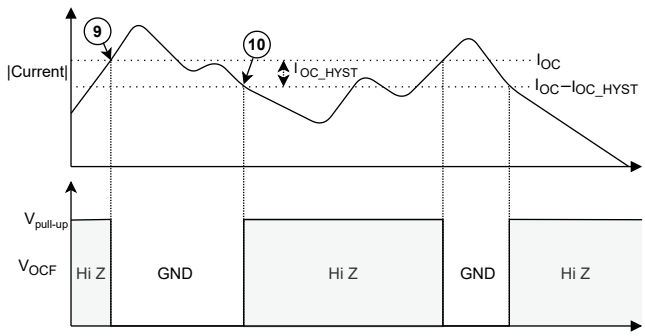

Figure 11: Fault Thresholds and OCF Pin Functionality

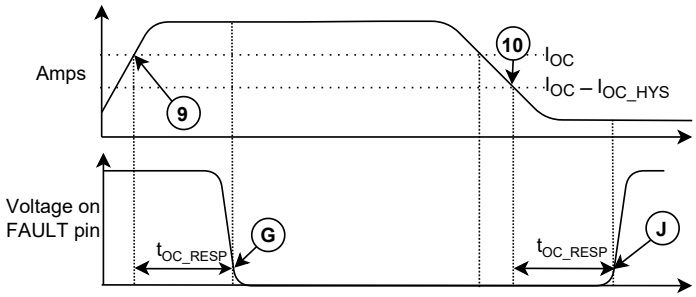

Figure 12: Fault Response Time

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THERMAL PERFORMANCE

Thermal Rise vs. Primary Current

During the design of any current-sensing system, self-heating due to the flow of current in the package IP conductor should be considered. As current moves through the system, the sensor, printed circuit board (PCB), and contacts to the PCB generate heat and act as a heat sink.

The thermal response is highly dependent on PCB layout, copper thickness, cooling techniques, and profile of the injected current. The current profile includes peak current value, current on-time, and duty cycle.

Placing vias under the copper pads of the Allegro current sensor evaluation board minimizes the current-path resistance and improves heat-sinking to the PCB, while placing vias outside of the pads limits the current path to the top of the PCB trace and has worse heat-sinking under the part (see Figure 13 and Figure 14).

The measured rise in steady-state die temperature of the package versus DC continuous current at an ambient temperature, T_A, of 25°C for two board designs—filled vias placed under copper pads and vias not placed under copper pads (vias outside pad)—is shown for the LZ package in Figure 15 and Figure 16 for the LZ and LC packages, respectively.

The measured rise in steady-state die temperature of the package versus DC continuous current at an ambient temperature of 25°C and an ambient temperature of 125°C is shown in Figure 17 and Figure 18 for the LZ and LC packages, respectively. The evaluation boards used have filled vias under the copper pads. Use of in-pad vias results in better thermal performance than non-use of in-pad vias.

The thermal capacity of the ACS37010/12 in the LZ package should be verified by the end user in the application-specific conditions. The maximum junction temperature, $T_{J(max)}$ (165°C), should not be exceeded. Measuring the temperature of the top of the package is a close approximation of the die temperature.

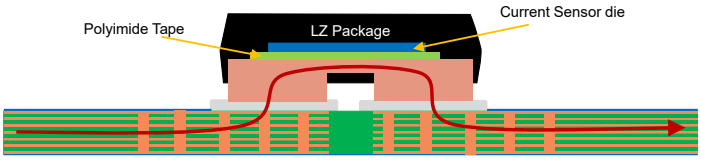

Figure 13: Vias Place Under Copper Pads, LZ Package

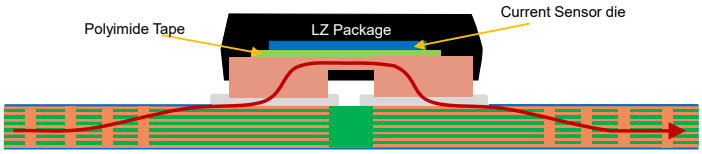

Figure 14: Vias Not Placed Under Copper Pads, LZ Package

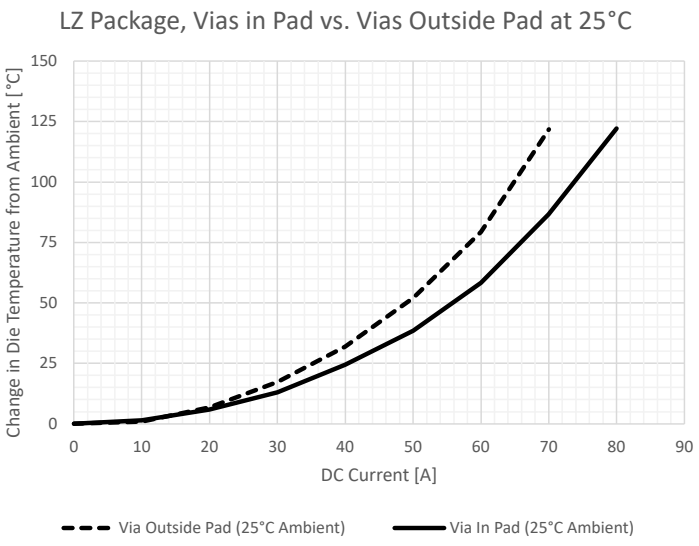

Figure 15: Comparison with and without In-Pad Vias at Ambient Temperature, LZ Package

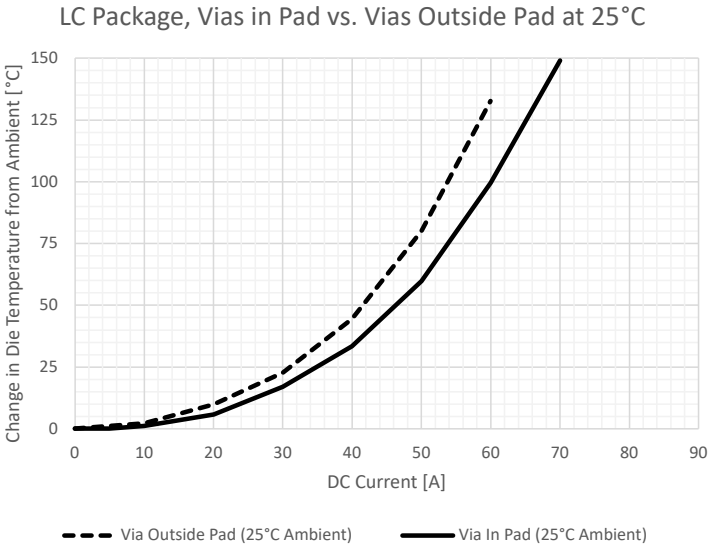

Figure 16: Comparison with and without In-Pad Vias at Ambient Temperature, LC Package

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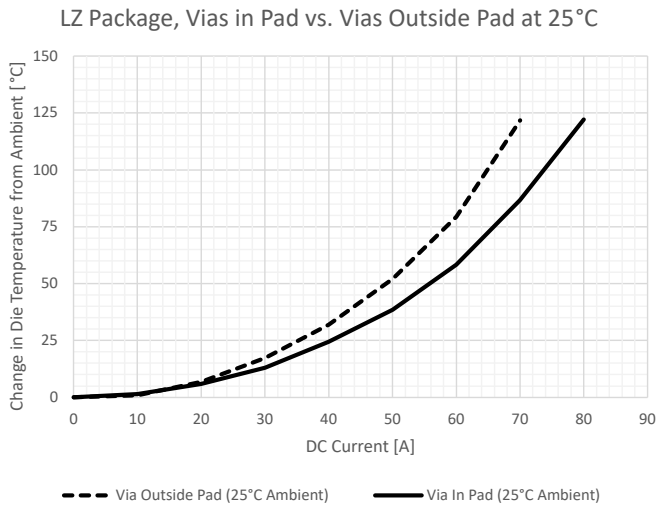

Figure 17: Comparison at 125°C and 25°C, In-Pad Vias, LZ Package

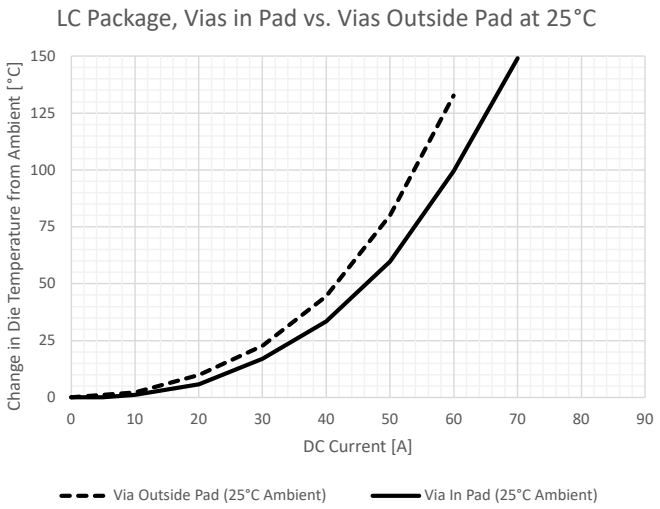

Figure 18: Comparison at 125°C and 25°C, In-Pad Vias, LC Package

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Safe Operating Region

Current applied to the IP pins of the ASC37010/12 in the LZ package heats the package, as illustrated in the Thermal Rise vs. Primary Current section. The amount of heating depends on the current applied and duration. The range of applied current, and duration of current, that is not detrimental to the part is shown in Figure 19.

If enough energy is applied, the copper IP lead melts and the fuse opens. This condition is represented by the blue line, "Time to Fuse" .

The maximum junction temperature is 165°C. If the maximum junction temperature is exceeded for an extended period of time the PN junctions on the die can become damaged. This condition can result in changes in the product performance, or it can create long-term reliability risks. The region in which this condition occurs is shown by the green line, "Time to 165°C".

The LZ package has a polyimide insulation barrier to enable high working voltages. Extended heating of the polyimide film causes deterioration of the material, reducing the insulation effectiveness of the package. This is shown by the red line, Time to Insulation Degradation.

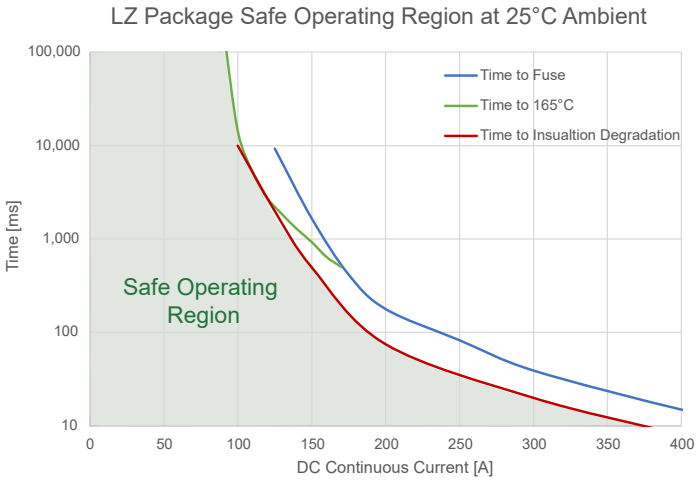

Figure 19: Safe Operating Region, LZ Package

Evaluation Board Layout

Thermal data shown in Figure 19 was collected using the LC/LZ Current Sensor Evaluation Board (ACSEVB-LC8-LZ6, TED-0004110). This board includes six layers and is shown in Figure 20.

Design support files for the ACSEVB-LC8-LZ6 evaluation board are available for download from the Allegro website. For more information, see the technical documents section of the ACS37010/12 webpage.

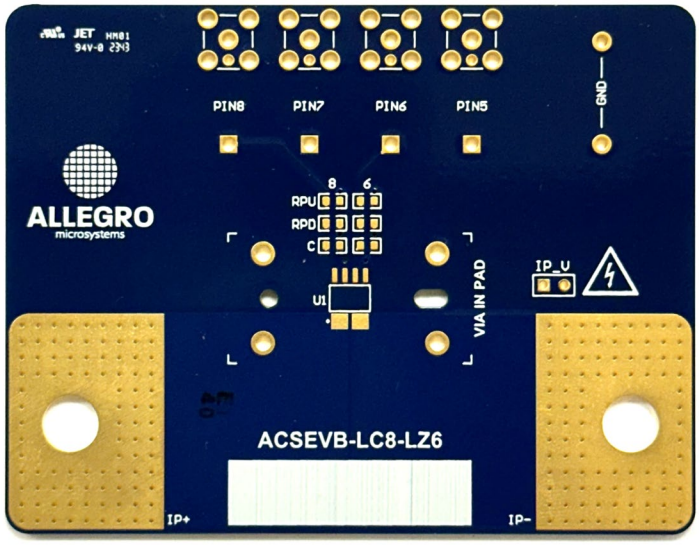

Figure 20: Allegro Evaluation Board, LZ or LC Package

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PACKAGE OUTLINE DRAWING

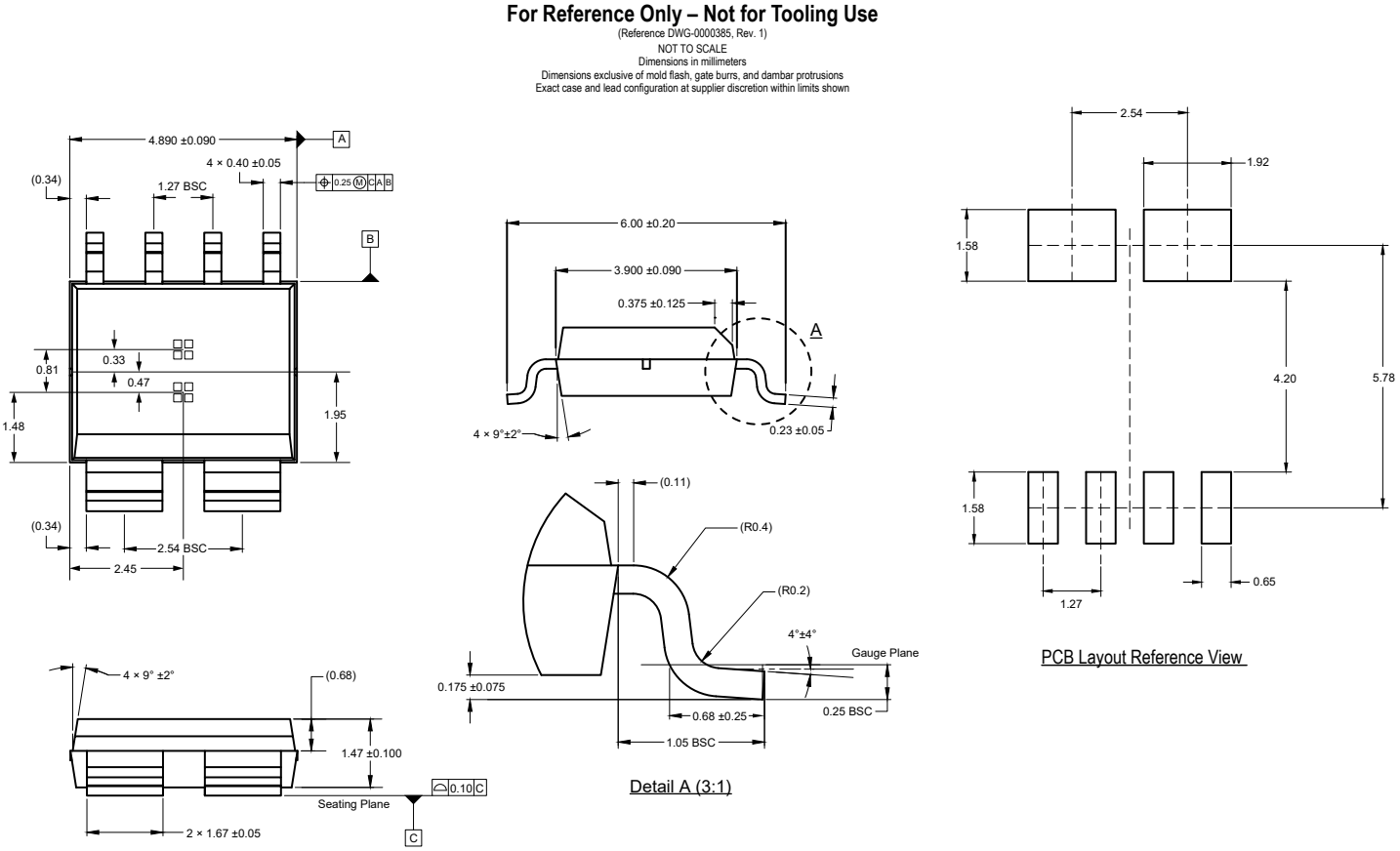
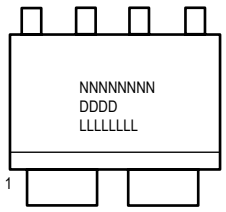


Figure 21: Custom 6-Pin SOIC (Suffix LZ)



Standard Branding Reference View

N = Device Part Number
D = Date Code
L = Assembly Lot Number

Figure 22: LZ Package, 6-Pin Fused-Lead SOIC

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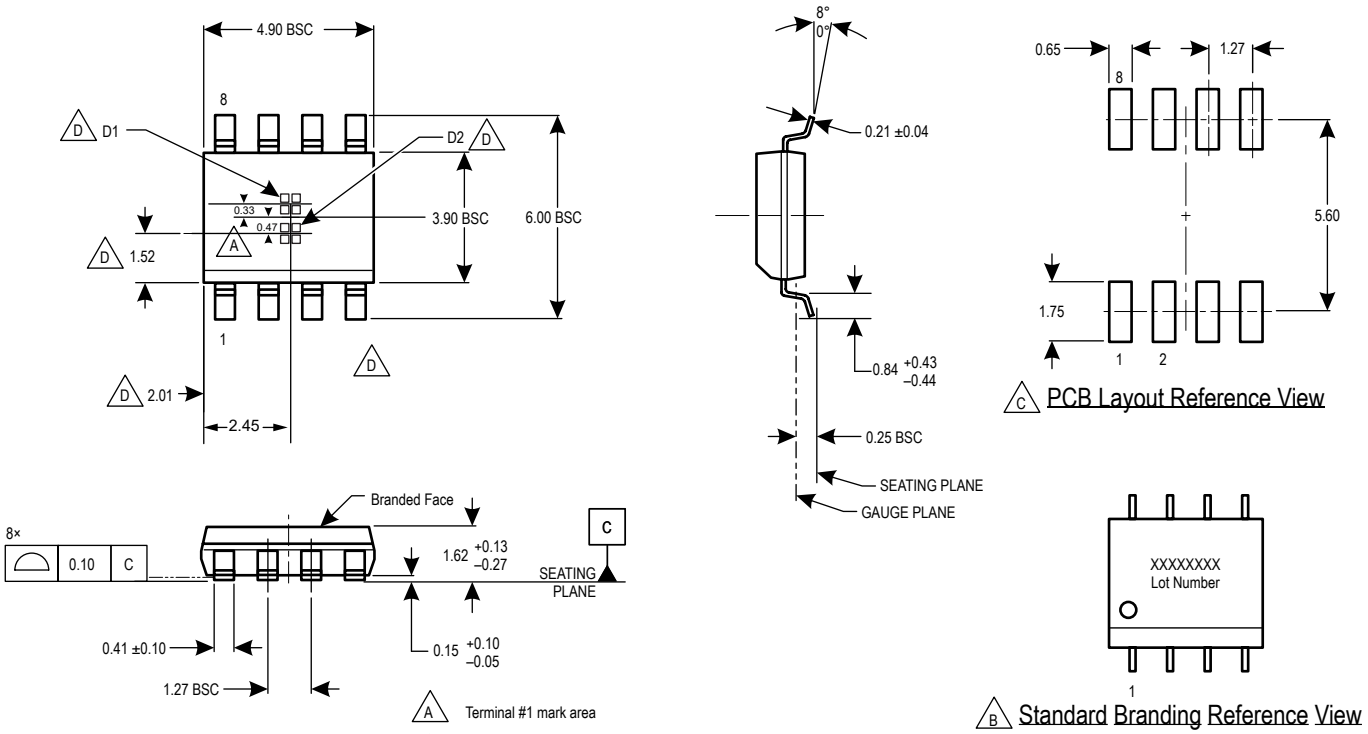
For Reference Only – Not for Tooling Use

(reference Allegro DWG-0000385, Rev. 2 or JEDEC MS-012AA)
Dimensions in millimeters – NOT TO SCALE
Dimensions exclusive of mold flash, gate burrs, and dambar protrusions
Exact case and lead configuration at supplier discretion within limits shown



A Terminal #1 mark area

B Branding scale and appearance at supplier discretion

C Reference land pattern layout (reference IPC7351 SOIC127P600X175-8M); all pads a minimum of 0.20 mm from all adjacent pads; adjust as necessary to meet application process requirements and PCB layout tolerances.

D Hall elements (D1 and D2); not to scale; the positions of the Hall plate elements are identical to the LZ package

Line 1, 2: Max. 8 characters per line
Belly Brand: 5 characters

Line 1: Part Number
Line 3: First 8 characters of Assembly Lot Number
Belly Brand: Country of Origin
Lot Number

Figure 23: LC Package, 8-Pin SOIC

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Revision History

Number	Date	Description
–	March 13, 2023	Initial release
1	March 29, 2023	Updated Error Components Including Lifetime Drift sections of Performance Characteristic tables (Pages 7, 8)
2	May 16, 2023	Added ACS37010LLZATR-030B5 and ACS37010LLZATR-030B3 part variants (all pages)
3	May 31, 2023	Added AEC-Q100 qualification to Features and Benefits (page 1)
4	November 9, 2023	Added ACS37012 variant
5	January 26, 2024	Added UL certification number (page 1), footnote 1, and Thermal Characteristics table (page 3); removed footnote 2 (page 3); corrected figure caption (page 5); updated Thermal Performance section (pages 24-25)
6	March 19, 2025	Minor editorial updates (all pages), added ACS37012LLZATR-030U5 part variant (page 2), improved isolation characteristics (page 3), corrected pinout and terminal list table (page 4), added footnotes [1] and [3] (page 7), added footnote [2] and clarified test conditions (page 8-15)
7	May 29, 2025	Updated Typical Application Circuit (page 1), Isolation Characteristics table (page 3)
8	November 18, 2025	Added LC package (throughout), added table of contents (page 2), updated selection table and part naming specification and changed internal conductor inductance characteristic (page 3), modified/ added output resistive/capacitive load characteristics (pages 7 and 8), and made minor editorial and formatting changes throughout.
9	February 3, 2026	Updated LC package part numbering throughout (pages 2, 3, 18–25), updated Selection Guide to add Features column (page 3), updated typical quiescent voltage output for ACS37010LLCTR-050B3 (page 21) and ACS37012LLCTR-050B5 (page 24), updated Power-on Operation and Undervoltage Threshold Detection subsections (page 28) and figures related to Power-State Thresholds with VOUT and VREF Behavior for a 5 V Device (page 29)
10	September 30, 2026	Updated package outline drawings (pages 37, 38)

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